## Notice of References Cited Application/Control No. 09/942,408 Examiner John Pezzlo Applicant(s)/Patent Under Reexamination FURUKAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-2003/0037167 A1	02-2003	Garcia-Luna-Aceves et al.	709/238
PK	В	US-6,393,012 B1	05-2002	Pankaj, Rajesh K.	370/342
X	С	US-5,987,011 A	11-1999	Toh, Chai Keong	370/331
	D	US-			
	E	US-			
	F	US-	-		
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	P					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

		NOTE A PROPERTY OF THE PROPERT
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.